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Understanding <u>Embedded - FPGAs (Field Programmable Gate Array)</u>

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details	
Product Status	Obsolete
Number of LABs/CLBs	84
Number of Logic Elements/Cells	672
Total RAM Bits	-
Number of I/O	120
Number of Gates	8000
Voltage - Supply	4.75V ~ 5.25V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 70°C (TA)
Package / Case	160-BQFP
Supplier Device Package	160-PQFP (28x28)
Purchase URL	https://www.e-xfl.com/product-detail/intel/epf8820aqc160-4

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Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

...and More Features

- Peripheral register for fast setup and clock-to-output delay
- Fabricated on an advanced SRAM process
- Available in a variety of packages with 84 to 304 pins (see Table 2)
- Software design support and automatic place-and-route provided by the Altera® MAX+PLUS® II development system for Windows-based PCs, as well as Sun SPARCstation, HP 9000 Series 700/800, and IBM RISC System/6000 workstations
- Additional design entry and simulation support provided by EDIF 2 0 0 and 3 0 0 netlist files, library of parameterized modules (LPM), Verilog HDL, VHDL, and other interfaces to popular EDA tools from manufacturers such as Cadence, Exemplar Logic, Mentor Graphics, OrCAD, Synopsys, Synplicity, and Veribest

Table 2. FLE.	Table 2. FLEX 8000 Package Options & I/O Pin Count Note (1)											
Device	84- Pin PLCC	100- Pin TQFP	144- Pin TQFP	160- Pin PQFP	160- Pin PGA	192- Pin PGA	208- Pin PQFP	225- Pin BGA	232- Pin PGA	240- Pin PQFP	280- Pin PGA	304- Pin RQFP
EPF8282A	68	78										
EPF8282AV		78										
EPF8452A	68	68		120	120							
EPF8636A	68			118		136	136					
EPF8820A			112	120		152	152	152				
EPF81188A							148		184	184		
EPF81500A										181	208	208

Note:

General Description

Altera's Flexible Logic Element MatriX (FLEX®) family combines the benefits of both erasable programmable logic devices (EPLDs) and field-programmable gate arrays (FPGAs). The FLEX 8000 device family is ideal for a variety of applications because it combines the fine-grained architecture and high register count characteristics of FPGAs with the high speed and predictable interconnect delays of EPLDs. Logic is implemented in LEs that include compact 4-input look-up tables (LUTs) and programmable registers. High performance is provided by a fast, continuous network of routing resources.

⁽¹⁾ FLEX 8000 device package types include plastic J-lead chip carrier (PLCC), thin quad flat pack (TQFP), plastic quad flat pack (PQFP), power quad flat pack (RQFP), ball-grid array (BGA), and pin-grid array (PGA) packages.

FLEX 8000 devices contain an optimized microprocessor interface that permits the microprocessor to configure FLEX 8000 devices serially, in parallel, synchronously, or asynchronously. The interface also enables the microprocessor to treat a FLEX 8000 device as memory and configure the device by writing to a virtual memory location, making it very easy for the designer to create configuration software.

The FLEX 8000 family is supported by Altera's MAX+PLUS II development system, a single, integrated package that offers schematic, text—including the Altera Hardware Description Language (AHDL), VHDL, and Verilog HDL—and waveform design entry, compilation and logic synthesis, simulation and timing analysis, and device programming. The MAX+PLUS II software provides EDIF 2 0 0 and 3 0 0, library of parameterized modules (LPM), VHDL, Verilog HDL, and other interfaces for additional design entry and simulation support from other industry-standard PC- and UNIX workstation-based EDA tools. The MAX+PLUS II software runs on Windows-based PCs and Sun SPARCstation, HP 9000 Series 700/800, and IBM RISC System/6000 workstations.

The MAX+PLUS II software interfaces easily with common gate array EDA tools for synthesis and simulation. For example, the MAX+PLUS II software can generate Verilog HDL files for simulation with tools such as Cadence Verilog-XL. Additionally, the MAX+PLUS II software contains EDA libraries that use device-specific features such as carry chains, which are used for fast counter and arithmetic functions. For instance, the Synopsys Design Compiler library supplied with the MAX+PLUS II development system includes DesignWare functions that are optimized for the FLEX 8000 architecture.



For more information on the MAX+PLUS II software, go to the MAX+PLUS II Programmable Logic Development System & Software Data Sheet.

Functional Description

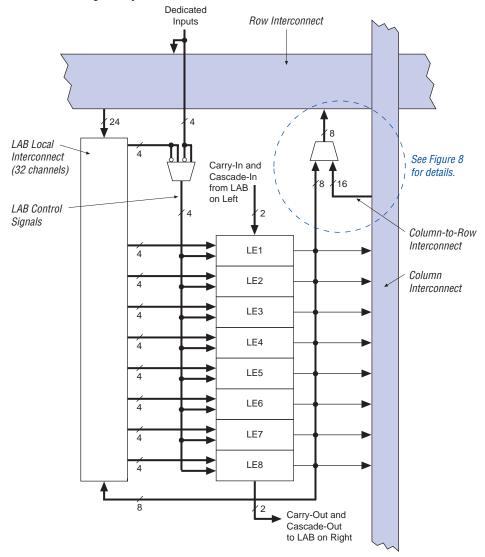
The FLEX 8000 architecture incorporates a large matrix of compact building blocks called logic elements (LEs). Each LE contains a 4-input LUT that provides combinatorial logic capability and a programmable register that offers sequential logic capability. The fine-grained structure of the LE provides highly efficient logic implementation.

Eight LEs are grouped together to form a logic array block (LAB). Each FLEX 8000 LAB is an independent structure with common inputs, interconnections, and control signals. The LAB architecture provides a coarse-grained structure for high device performance and easy routing.

Logic Array Block

A logic array block (LAB) consists of eight LEs, their associated carry and cascade chains, LAB control signals, and the LAB local interconnect. The LAB provides the coarse-grained structure of the FLEX 8000 architecture. This structure enables FLEX 8000 devices to provide efficient routing, high device utilization, and high performance. Figure 2 shows a block diagram of the FLEX 8000 LAB.



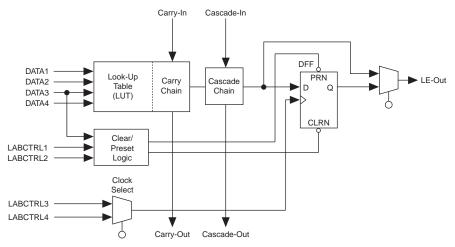


Each LAB provides four control signals that can be used in all eight LEs. Two of these signals can be used as clocks, and the other two for clear/preset control. The LAB control signals can be driven directly from a dedicated input pin, an I/O pin, or any internal signal via the LAB local interconnect. The dedicated inputs are typically used for global clock, clear, or preset signals because they provide synchronous control with very low skew across the device. FLEX 8000 devices support up to four individual global clock, clear, or preset control signals. If logic is required on a control signal, it can be generated in one or more LEs in any LAB and driven into the local interconnect of the target LAB.

Logic Element

The logic element (LE) is the smallest unit of logic in the FLEX 8000 architecture, with a compact size that provides efficient logic utilization. Each LE contains a 4-input LUT, a programmable flipflop, a carry chain, and cascade chain. Figure 3 shows a block diagram of an LE.

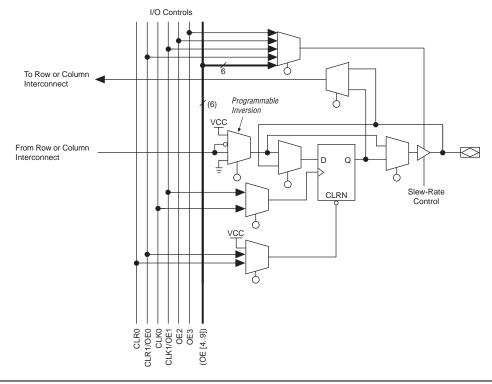
Figure 3. FLEX 8000 LE



The LUT is a function generator that can quickly compute any function of four variables. The programmable flipflop in the LE can be configured for D, T, JK, or SR operation. The clock, clear, and preset control signals on the flipflop can be driven by dedicated input pins, general-purpose I/O pins, or any internal logic. For purely combinatorial functions, the flipflop is bypassed and the output of the LUT goes directly to the output of the LE.

Figure 10. FLEX 8000 IOE

Numbers in parentheses are for EPF81500A devices only.



Row-to-IOE Connections

Figure 11 illustrates the connection between row interconnect channels and IOEs. An input signal from an IOE can drive two separate row channels. When an IOE is used as an output, the signal is driven by an *n*-to-1 multiplexer that selects the row channels. The size of the multiplexer varies with the number of columns in a device. EPF81500A devices use a 27-to-1 multiplexer; EPF81188A, EPF8820A, EPF8636A, and EPF8452A devices use a 21-to-1 multiplexer; and EPF8282A and EPF8282AV devices use a 13-to-1 multiplexer. Eight IOEs are connected to each side of the row channels.

The instruction register length for FLEX 8000 devices is three bits. Table 7 shows the boundary-scan register length for FLEX 8000 devices.

Table 7. FLEX 8000 Boundary-Scan Register Length					
Device	Boundary-Scan Register Length				
EPF8282A, EPF8282AV	273				
EPF8636A	417				
EPF8820A	465				
EPF81500A	645				

FLEX 8000 devices that support JTAG include weak pull-ups on the JTAG pins. Figure 14 shows the timing requirements for the JTAG signals.

TDI

TCK

t_{JCP}

t_{JCL}

t_{JPSU}

t_{JPSU}

t_{JPNZ}

TDO

Signal to Be Captured
Signal to Be Driven

Figure 14. EPF8282A, EPF8282AV, EPF8636A, EPF8820A & EPF81500A JTAG Waveforms

Table 8 shows the timing parameters and values for EPF8282A, EPF8282AV, EPF8636A, EPF8820A, and EPF81500A devices.

Symbol	Parameter	Conditions	Min	Max	Unit
V _{CCINT}	Supply voltage for internal logic and input buffers	(3), (4)	4.75 (4.50)	5.25 (5.50)	V
V _{CCIO}	Supply voltage for output buffers, 5.0-V operation	(3), (4)	4.75 (4.50)	5.25 (5.50)	V
	Supply voltage for output buffers, 3.3-V operation	(3), (4)	3.00 (3.00)	3.60 (3.60)	V
V _I	Input voltage		-0.5	V _{CCINT} + 0.5	V
Vo	Output voltage		0	V _{CCIO}	V
T _A	Operating temperature	For commercial use	0	70	°C
		For industrial use	-40	85	°C
t _R	Input rise time			40	ns
t _F	Input fall time			40	ns

Table 1	1. FLEX 8000 5.0-V Device DO	Operating Conditions	Notes (5), (6)			
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{IH}	High-level input voltage		2.0		V _{CCINT} + 0.5	V
V _{IL}	Low-level input voltage		-0.5		0.8	V
V _{OH}	5.0-V high-level TTL output voltage	$I_{OH} = -4 \text{ mA DC } (7)$ $V_{CCIO} = 4.75 \text{ V}$	2.4			V
	3.3-V high-level TTL output voltage	$I_{OH} = -4 \text{ mA DC } (7)$ $V_{CCIO} = 3.00 \text{ V}$	2.4			V
	3.3-V high-level CMOS output voltage	$I_{OH} = -0.1 \text{ mA DC } (7)$ $V_{CCIO} = 3.00 \text{ V}$	V _{CCIO} - 0.2			V
V _{OL}	5.0-V low-level TTL output voltage	I _{OL} = 12 mA DC (7) V _{CCIO} = 4.75 V			0.45	V
	3.3-V low-level TTL output voltage	I _{OL} = 12 mA DC (7) V _{CCIO} = 3.00 V			0.45	V
	3.3-V low-level CMOS output voltage	I _{OL} = 0.1 mA DC (7) V _{CCIO} = 3.00 V			0.2	V
I _I	Input leakage current	$V_I = V_{CC}$ or ground	-10		10	μΑ
I _{OZ}	Tri-state output off-state current	$V_O = V_{CC}$ or ground	-40		40	μA
I _{CC0}	V _{CC} supply current (standby)	V _I = ground, no load		0.5	10	mA

Table 1	Table 12. FLEX 8000 5.0-V Device Capacitance Note (8)							
Symbol	Parameter	Conditions	Min	Max	Unit			
C _{IN}	Input capacitance	V _{IN} = 0 V, f = 1.0 MHz		10	pF			
C _{OUT}	Output capacitance	V _{OUT} = 0 V, f = 1.0 MHz		10	pF			

Notes to tables:

- (1) See the Operating Requirements for Altera Devices Data Sheet.
- (2) Minimum DC input is -0.5 V. During transitions, the inputs may undershoot to -2.0 V or overshoot to 7.0 V for input currents less than 100 mA and periods shorter than 20 ns.
- (3) The maximum V_{CC} rise time is 100 ms.
- (4) Numbers in parentheses are for industrial-temperature-range devices.
- (5) Typical values are for $T_A = 25^{\circ} \text{ C}$ and $V_{CC} = 5.0 \text{ V}$.
- (6) These values are specified in Table 10 on page 28.
- (7) The I_{OH} parameter refers to high-level TTL or CMOS output current; the I_{OL} parameter refers to low-level TTL or CMOS output current.
- (8) Capacitance is sample-tested only.

Tables 13 through 16 provide information on absolute maximum ratings, recommended operating conditions, operating conditions, and capacitance for 3.3-V FLEX 8000 devices.

Table 1	Table 13. FLEX 8000 3.3-V Device Absolute Maximum RatingsNote (1)							
Symbol	Parameter	Conditions	Min	Max	Unit			
V _{CC}	Supply voltage	With respect to ground (2)	-2.0	5.3	V			
V _I	DC input voltage		-2.0	5.3	V			
I _{OUT}	DC output current, per pin		-25	25	mA			
T _{STG}	Storage temperature	No bias	-65	150	° C			
T_{AMB}	Ambient temperature	Under bias	-65	135	° C			
T_{J}	Junction temperature	Plastic packages, under bias		135	° C			

Table 1	Table 14. FLEX 8000 3.3-V Device Recommended Operating Conditions							
Symbol	Parameter	Conditions	Min	Max	Unit			
V _{CC}	Supply voltage	(3)	3.0	3.6	V			
V _I	Input voltage		-0.3	V _{CC} + 0.3	V			
Vo	Output voltage		0	V _{CC}	V			
T _A	Operating temperature	For commercial use	0	70	° C			
t _R	Input rise time			40	ns			
t _F	Input fall time			40	ns			

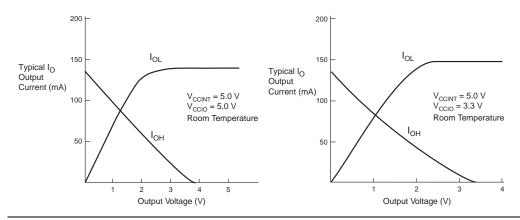


Figure 16. Output Drive Characteristics of 5.0-V FLEX 8000 Devices (Except EPF8282A)

Figure 17 shows the typical output drive characteristics of 5.0-V EPF8282A devices. The output driver is compliant with *PCI Local Bus Specification, Revision* 2.2.

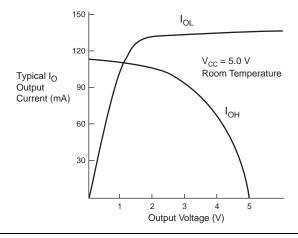


Figure 17. Output Drive Characteristics of EPF8282A Devices with 5.0-V V_{CCIO}

Figure 18 shows the typical output drive characteristics of EPF8282AV devices.

Table 19. FLEX 8000 Interconnect Timing Parameters Note (1)					
Symbol	Parameter				
t _{LABCASC}	Cascade delay between LEs in different LABs				
t _{LABCARRY}	Carry delay between LEs in different LABs				
t _{LOCAL}	LAB local interconnect delay				
t _{ROW}	Row interconnect routing delay (4)				
t_{COL}	Column interconnect routing delay				
t _{DIN_C}	Dedicated input to LE control delay				
t _{DIN_D}	Dedicated input to LE data delay (4)				
t _{DIN_IO}	Dedicated input to IOE control delay				

Table 20. FLEX 8	Table 20. FLEX 8000 External Reference Timing Characteristics Note (5)					
Symbol	Parameter					
t _{DRR}	gister-to-register delay via 4 LEs, 3 row interconnects, and 4 local interconnects (6)					
t _{ODH}	Output data hold time after clock (7)					

Notes to tables:

- (1) Internal timing parameters cannot be measured explicitly. They are worst-case delays based on testable and external parameters specified by Altera. Internal timing parameters should be used for estimating device performance. Post-compilation timing simulation or timing analysis is required to determine actual worst-case performance.
- (2) These values are specified in Table 10 on page 28 or Table 14 on page 29.
- (3) For the t_{OD3} and t_{ZX3} parameters, $V_{CCIO} = 3.3 \text{ V or } 5.0 \text{ V}$.
- (4) The t_{ROW} and t_{DIN_D} delays are worst-case values for typical applications. Post-compilation timing simulation or timing analysis is required to determine actual worst-case performance.
- (5) External reference timing characteristics are factory-tested, worst-case values specified by Altera. A representative subset of signal paths is tested to approximate typical device applications.
- (6) For more information on test conditions, see *Application Note 76* (*Understanding FLEX 8000 Timing*).
- (7) This parameter is a guideline that is sample-tested only and is based on extensive device characterization. This parameter applies to global and non-global clocking, and for LE and I/O element registers.

The FLEX 8000 timing model shows the delays for various paths and functions in the circuit. See Figure 19. This model contains three distinct parts: the LE; the IOE; and the interconnect, including the row and column FastTrack Interconnect, LAB local interconnect, and carry and cascade interconnect paths. Each parameter shown in Figure 19 is expressed as a worst-case value in Tables 22 through 49. Hand-calculations that use the FLEX 8000 timing model and these timing parameters can be used to estimate FLEX 8000 device performance. Timing simulation or timing analysis after compilation is required to determine the final worst-case performance. Table 21 summarizes the interconnect paths shown in Figure 19.



For more information on timing parameters, go to *Application Note 76* (*Understanding FLEX 8000 Timing*).

Symbol			Speed	Grade			Unit
	A-2		A-3		A-4		1
	Min	Max	Min	Max	Min	Max	1
t _{LABCASC}		0.3		0.3		0.4	ns
t _{LABCARRY}		0.3		0.3		0.4	ns
t _{LOCAL}		0.5		0.6		0.8	ns
t _{ROW}		4.2		4.2		4.2	ns
t_{COL}		2.5		2.5		2.5	ns
t _{DIN_C}		5.0		5.0		5.5	ns
t _{DIN_D}		7.2		7.2		7.2	ns
t _{DIN_IO}		5.0		5.0		5.5	ns

Table 28. EPF8282AV Logic Element Timing Parameters									
Symbol		Speed	l Grade		Unit				
	A-3		A						
	Min	Max	Min	Max	•				
t_{LUT}		3.2		7.3	ns				
t _{CLUT}		0.0		1.4	ns				
t _{RLUT}		1.5		5.1	ns				
t _{GATE}		0.0		0.0	ns				
t _{CASC}		0.9		2.8	ns				
t _{CICO}		0.6		1.5	ns				
t _{CGEN}		0.7		2.2	ns				
t _{CGENR}		1.5		3.7	ns				
$t_{\rm C}$		2.5		4.7	ns				
t _{CH}	4.0		6.0		ns				
t_{CL}	4.0		6.0		ns				
t_{CO}		0.6		0.9	ns				
t _{COMB}		0.6		0.9	ns				
t _{SU}	1.2		2.4		ns				
t_H	1.5		4.6		ns				
t _{PRE}		0.8		1.3	ns				
t _{CLR}		0.8		1.3	ns				

Table 29. EPF8282AV External Timing Parameters									
Symbol		Speed Grade Unit							
		A-3 A-4							
	Min	Min Max		Max					
t _{DRR}		24.8		50.1	ns				
t _{ODH}	1.0		1.0		ns				

Symbol			Speed	Grade			Unit
	A-2		A	-3	A-4		1
	Min	Max	Min	Max	Min	Max	
t_{LUT}		2.0		2.3		3.0	ns
t _{CLUT}		0.0		0.2		0.1	ns
t _{RLUT}		0.9		1.6		1.6	ns
t_{GATE}		0.0		0.0		0.0	ns
t _{CASC}		0.6		0.7		0.9	ns
t _{CICO}		0.4		0.5		0.6	ns
t _{CGEN}		0.4		0.9		0.8	ns
t _{CGENR}		0.9		1.4		1.5	ns
$t_{\rm C}$		1.6		1.8		2.4	ns
t _{CH}	4.0		4.0		4.0		ns
t_{CL}	4.0		4.0		4.0		ns
$t_{\rm CO}$		0.4		0.5		0.6	ns
t _{COMB}		0.4		0.5		0.6	ns
t _{SU}	0.8		1.0		1.1		ns
t _H	0.9		1.1		1.4		ns
t _{PRE}		0.6		0.7		0.8	ns
t _{CLR}		0.6		0.7		0.8	ns

Table 33. EPF845.	2A External Til	ming Paramet	ers					
Symbol	Speed Grade							
	A	A-2		A-3		A-4		
	Min	Max	Min	Max	Min	Max	1	
t _{DRR}		16.0		20.0		25.0	ns	
t _{ODH}	1.0		1.0		1.0		ns	

Table 40. EPF882	Table 40. EPF8820A LE Timing Parameters										
Symbol			Speed	Grade			Unit				
	A-2		A	-3	A	1-4					
	Min	Max	Min	Max	Min	Max					
t_{LUT}		2.0		2.5		3.2	ns				
t _{CLUT}		0.0		0.0		0.0	ns				
t _{RLUT}		0.9		1.1		1.5	ns				
t_{GATE}		0.0		0.0		0.0	ns				
t _{CASC}		0.6		0.7		0.9	ns				
t _{CICO}		0.4		0.5		0.6	ns				
t _{CGEN}		0.4		0.5		0.7	ns				
t _{CGENR}		0.9		1.1		1.5	ns				
t_C		1.6		2.0		2.5	ns				
t _{CH}	4.0		4.0		4.0		ns				
t _{CL}	4.0		4.0		4.0		ns				
t_{CO}		0.4		0.5		0.6	ns				
t _{COMB}		0.4		0.5		0.6	ns				
t _{SU}	0.8		1.1		1.2		ns				
t _H	0.9		1.1		1.5		ns				
t _{PRE}		0.6		0.7		0.8	ns				
t _{CLR}		0.6		0.7		0.8	ns				

Table 41. EPF882	?OA External T	iming Parame	ters					
Symbol	Speed Grade							
	A-2 A-3			-3	A	1		
	Min	Max	Min	Max	Min	Max		
t _{DRR}		16.0		20.0		25.0	ns	
t _{ODH}	1.0		1.0		1.0		ns	

Table 48. EPF81500A LE Timing Parameters										
Symbol			Speed	Grade			Unit			
	A	-2	А	-3	A	-4				
	Min	Max	Min	Max	Min	Max				
t_{LUT}		2.0		2.5		3.2	ns			
t_{CLUT}		0.0		0.0		0.0	ns			
t _{RLUT}		0.9		1.1		1.5	ns			
t _{GATE}		0.0		0.0		0.0	ns			
t _{CASC}		0.6		0.7		0.9	ns			
t_{CICO}		0.4		0.5		0.6	ns			
t _{CGEN}		0.4		0.5		0.7	ns			
t _{CGENR}		0.9		1.1		1.5	ns			
t_C		1.6		2.0		2.5	ns			
t _{CH}	4.0		4.0		4.0		ns			
t_{CL}	4.0		4.0		4.0		ns			
t_{CO}		0.4		0.5		0.6	ns			
t _{COMB}		0.4		0.5		0.6	ns			
t _{SU}	0.8		1.1		1.2		ns			
t _H	0.9		1.1		1.5		ns			
t _{PRE}		0.6		0.7		0.8	ns			
t _{CLR}		0.6		0.7		0.8	ns			

Table 49. EPF81500A External Timing Parameters										
Symbol	Speed Grade									
	A-2 A-3				A-]				
	Min	Max	Min	Max	Min	Max				
t _{DRR}		16.1		20.1		25.1	ns			
t _{ODH}	1.0		1.0		1.0		ns			

Operating Modes

The FLEX 8000 architecture uses SRAM elements that require configuration data to be loaded whenever the device powers up and begins operation. The process of physically loading the SRAM programming data into the device is called *configuration*. During initialization, which occurs immediately after configuration, the device resets registers, enables I/O pins, and begins to operate as a logic device. The I/O pins are tri-stated during power-up, and before and during configuration. The configuration and initialization processes together are called *command mode*; normal device operation is called *user mode*.

SRAM elements allow FLEX 8000 devices to be reconfigured in-circuit with new programming data that is loaded into the device. Real-time reconfiguration is performed by forcing the device into command mode with a device pin, loading different programming data, reinitializing the device, and resuming user-mode operation. The entire reconfiguration process requires less than 100 ms and can be used to dynamically reconfigure an entire system. In-field upgrades can be performed by distributing new configuration files.

Configuration Schemes

The configuration data for a FLEX 8000 device can be loaded with one of six configuration schemes, chosen on the basis of the target application. Both active and passive schemes are available. In the active configuration schemes, the FLEX 8000 device functions as the controller, directing the loading operation, controlling external configuration devices, and completing the loading process. The clock source for all active configuration schemes is an oscillator on the FLEX 8000 device that operates between 2 MHz and 6 MHz. In the passive configuration schemes, an external controller guides the FLEX 8000 device. Table 51 shows the data source for each of the six configuration schemes.

Table 51. Data Source for Configura	Table 51. Data Source for Configuration								
Configuration Scheme	Acronym	Data Source							
Active serial	AS	Altera configuration device							
Active parallel up	APU	Parallel configuration device							
Active parallel down	APD	Parallel configuration device							
Passive serial	PS	Serial data path							
Passive parallel synchronous	PPS	Intelligent host							
Passive parallel asynchronous	PPA	Intelligent host							

Device Pin-Outs

Tables 52 through 54 show the pin names and numbers for the dedicated pins in each FLEX 8000 device package.

Table 52. FLEX		·		1	1	T	T
Pin Name	84-Pin PLCC EPF8282A	84-Pin PLCC EPF8452A EPF8636A	100-Pin TQFP EPF8282A EPF8282AV	100-Pin TQFP EPF8452A	144-Pin TQFP EPF8820A	160-Pin PGA EPF8452A	160-Pin PQFP EPF8820A
nSP (2)	75	75	75	76	110	R1	1
MSEL0 (2)	74	74	74	75	109	P2	2
MSEL1 (2)	53	53	51	51	72	A1	44
nSTATUS (2)	32	32	24	25	37	C13	82
nCONFIG (2)	33	33	25	26	38	A15	81
DCLK (2)	10	10	100	100	143	P14	125
CONF_DONE (2)	11	11	1	1	144	N13	124
nWS	30	30	22	23	33	F13	87
nRS	48	48	42	45	31	C6	89
RDCLK	49	49	45	46	12	B5	110
nCS	29	29	21	22	4	D15	118
CS	28	28	19	21	3	E15	121
RDYnBUSY	77	77	77	78	20	P3	100
CLKUSR	50	50	47	47	13	C5	107
ADD17	51	51	49	48	75	B4	40
ADD16	36	55	28	54	76	E2	39
ADD15	56	56	55	55	77	D1	38
ADD14	57	57	57	57	78	E1	37
ADD13	58	58	58	58	79	F3	36
ADD12	60	60	59	60	83	F2	32
ADD11	61	61	60	61	85	F1	30
ADD10	62	62	61	62	87	G2	28
ADD9	63	63	62	64	89	G1	26
ADD8	64	64	64	65	92	H1	22
ADD7	65	65	65	66	94	H2	20
ADD6	66	66	66	67	95	J1	18
ADD5	67	67	67	68	97	J2	16
ADD4	69	69	68	70	102	K2	11
ADD3	70	70	69	71	103	K1	10
ADD2	71	71	71	72	104	K3	8
ADD1	76	72	76	73	105	M1	7

Pin Name	160-Pin PQFP EPF8452A	160-Pin PQFP EPF8636A	192-Pin PGA EPF8636A EPF8820A	208-Pin PQFP EPF8636A (1)	208-Pin PQFP EPF8820A (1)	208-Pin PQFP EPF81188A (1)
DATA4	154	127	E17	165	172	170
DATA3	157	124	G15	162	171	168
DATA2	159	122	F15	160	167	166
DATA1	11	115	E16	149	165	163
DATA0	12	113	C16	147	162	161
SDOUT (3)	128	152	C7 (11)	198	124	119
TDI (4)	_	55	R11	72	20	_
TDO (4)	_	95	B9	120	129	_
TCK (4), (6)	_	57	U8	74	30	_
TMS (4)	_	59	U7	76	32	_
TRST (7)	-	40	R3	54	54	-
Dedicated Inputs (10)	5, 36, 85, 116	6, 35, 87, 116	A5, U5, U13, A13	7, 45, 112, 150	17, 36, 121, 140	13, 41, 116, 146
VCCINT (5.0 V)	21, 41, 53, 67, 80, 81, 100, 121, 133, 147, 160	4, 5, 26, 85, 106	C8, C9, C10, R8, R9, R10, R14	5, 6, 33, 110, 137	5, 6, 27, 48, 119, 141	4, 20, 35, 48, 50, 102, 114, 131, 147
VCCIO (5.0 V or 3.3 V)	_	25, 41, 60, 70, 80, 107, 121, 140, 149, 160	D3, D4, D9, D14, D15, G4, G14, L4, L14, P4, P9, P14	32, 55, 78, 91, 102, 138, 159, 182, 193, 206	26, 55, 69, 87, 102, 131, 159, 173, 191, 206	3, 19, 34, 49, 69, 87, 106, 123, 140, 156, 174, 192
GND	13, 14, 28, 46, 60, 75, 93, 107, 108, 126, 140, 155	15, 16, 36, 37, 45, 51, 75, 84, 86, 96, 97, 117, 126, 131, 154	C4, D7, D8, D10, D11, H4, H14, K4, K14, P7, P8, P10, P11	19, 20, 46, 47, 60, 67, 96, 109, 111, 124, 125, 151, 164, 171, 200	15, 16, 37, 38, 60, 78, 96, 109, 110, 120, 130, 142, 152, 164, 182, 200	11, 12, 27, 28, 42, 43, 60, 78, 96, 105, 115, 122, 132, 139, 148, 155, 159, 165, 183, 201
No Connect (N.C.)	2, 3, 38, 39, 70, 82, 83, 118, 119, 148	2, 39, 82, 119	C6, C12, C13, C14, E3, E15, F3, J3, J4, J14, J15, N3, N15, P3, P15, R4 (12)	1, 2, 3, 16, 17, 18, 25, 26, 27, 34, 35, 36, 50, 51, 52, 53, 104, 105, 106, 107, 121, 122, 123, 130, 131, 132, 139, 140, 141, 154, 155, 156, 157, 208	1, 2, 3, 50, 51, 52, 53, 104, 105, 106, 107, 154, 155, 156, 157, 208	1, 2, 51, 52, 53, 54, 103, 104, 157, 158, 207, 208
Total User I/O Pins (9)	116	114	132, 148 (13)	132	148	144

Pin Name	225-Pin BGA EPF8820A	232-Pin PGA EPF81188A	240-Pin PQFP EPF81188A	240-Pin PQFP EPF81500A	280-Pin PGA EPF81500A	304-Pin RQFP EPF81500A
D3.003.4	A5	C7	198	194	W16	248
DATA4		D7	196	193	W17	246
DATA3	B5					
DATA2	E6	B5	194	190	V16	243
DATA1	D5	A3	191	189	U16	241
DATA0	C4	A2	189	187	V17	239
SDOUT (3)	K1	N2	135	136	F19	169
TDI	F15 (4)	_	_	63 (14)	B1 (14)	80 (14)
TDO	J2 (4)	-	_	117	C17	149
TCK (6)	J14 (4)	_	_	116 <i>(14)</i>	A19 (14)	148 (14)
TMS	J12 (4)	_	_	64 (14)	C2 (14)	81 (14)
TRST (7)	P14	_	_	115 <i>(14)</i>	A18 (14)	145 (14)
Dedicated Inputs	F4, L1, K12,	C1, C17, R1,	10, 51, 130,	8, 49, 131,	F1, F16, P3,	12, 64, 164,
(10)	E15	R17	171	172	P19	217
VCCINT	F5, F10, E1,	E4, H4, L4,	20, 42, 64, 66,	18, 40, 60, 62,	B17, D3, D15,	24, 54, 77,
(5.0 V)	L2, K4, M12, P15, H13, H14, B15, C13	P12, L14, H14, E14, R14, U1	114, 128, 150, 172, 236	91, 114, 129, 151, 173, 209, 236	E8, E10, E12, E14, R7, R9, R11, R13, R14, T14	144, 79, 115, 162, 191, 218, 266, 301
VCCIO (5.0 V or 3.3 V)	H3, H2, P6, R6, P10, N10, R14, N13, H15, H12, D12, A14, B10, A10, B6, C6, A2, C3, M4, R2	N10, M13, M5, K13, K5, H13, H5, F5, E10, E8, N8, F13	19, 41, 65, 81, 99, 116, 140, 162, 186, 202, 220, 235	17, 39, 61, 78, 94, 108, 130, 152, 174, 191, 205, 221, 235	D14, E7, E9, E11, E13, R6, R8, R10, R12, T13, T15	

Table 54. FLEX 8000 225-, 232-, 240-, 280- & 304-Pin Package Pin-Outs (Part 3 of 3)						
Pin Name	225-Pin BGA EPF8820A	232-Pin PGA EPF81188A	240-Pin PQFP EPF81188A	240-Pin PQFP EPF81500A	280-Pin PGA EPF81500A	304-Pin RQFP EPF81500A
GND	B1, D4, E14, F7, F8, F9, F12, G6, G7, G8, G9, G10, H1, H4, H5, H6, H7, H8, H9, H10, H11, J6, J7, J8, J9, J10, K6, K7, K8, K9, K11, L15, N3, P1	A1, D6, E11, E7, E9, G4, G5, G13, G14, J5, J13, K4, K14, L5, L13, N4, N7, N9, N11, N14	173, 185, 187, 193, 211, 229	119, 140, 141, 162, 163, 184,	E15, E16, F5, F15, G5, G15, H5, H15, J5, J15, K5, K15,	151,175,177, 206,208,231, 232,237,253, 265, 273, 291
No Connect (N.C.)		_	61, 62, 119, 120, 181, 182, 239, 240	_	_	10, 21, 23, 25, 35, 37, 39, 40, 41, 42, 52, 55, 66, 68, 146, 147, 161, 173, 174, 176, 187, 188, 189, 190, 192, 194, 195, 205, 207, 219, 221, 233, 234, 235, 236, 302, 303
Total User I/O Pins (9)	148	180	180	177	204	204